REVISIONS				
LTR	DESCRIPTION		DATE (YR-MO-DA)	APPROVED

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REV STATUS OF SHEETS	**REV**																							
	SHEET	1	2	3	4	5	6	7	8	9	10												

PMIC N/A	PREPARED BY *Monica Poelking*	DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444			
STANDARDIZED MILITARY DRAWING	CHECKED BY *Ray Monnin*				
	APPROVED BY	MICROCIRCUIT, DIGITAL, HIGH SPEED CMOS, HEX INVERTERS, MONOLITHIC SILICON			
THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE	DRAWING APPROVAL DATE 03 MARCH 1989	SIZE **A**	CAGE CODE **67268**	**5962-88718**	
	REVISION LEVEL				
AMSC N/A		SHEET 1 OF 10			

DESC FORM 193
SEP 87

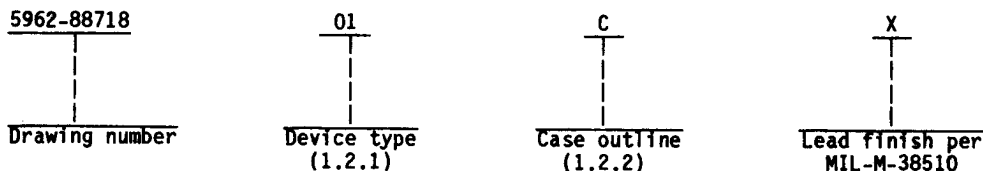* U.S. GOVERNMENT PRINTING OFFICE: 1987 — 748-129/60911

5962-E1020

1. SCOPE

1.1 <u>Scope</u>. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 <u>Part number</u>. The complete part number shall be as shown in the following example:

```
  5962-88718              01                 C                   X
      |                   |                  |                   |
      |                   |                  |                   |
      |                   |                  |                   |
 Drawing number      Device type       Case outline      Lead finish per
                      (1.2.1)           (1.2.2)           MIL-M-38510
```

1.2.1 <u>Device type</u>. The device type shall identify the circuit function as follows:

Device type	Generic number	Circuit function
01	54HC05	Hex inverters with open-drain outputs

1.2.2 <u>Case outlines</u>. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter	Case outline
C	D-1 (14-lead, .785" x .310" x .200"), dual-in-line package
2	C-2 (20-terminal, .358" x .358" x .100"), square chip carrier package

1.3 <u>Absolute maximum ratings</u>. 1/

Supply voltage range - - - - - - - - - - - - - - - - -	-0.5 V dc to +7.0 V dc
DC input voltage - - - - - - - - - - - - - - - - - - -	-0.5 V dc to V_{CC} + 0.5 V dc
DC output voltage - - - - - - - - - - - - - - - - - -	-0.5 V dc to V_{CC} + 0.5 V dc
Clamp diode current - - - - - - - - - - - - - - - -	±20 mA
DC output current (per pin) - - - - - - - - - - - -	±25 mA
DC V_{CC} or GND current (per pin) - - - - - - - - - -	±50 mA
Continuous power dissipation (P_D) 2/ - - - - - - - -	+500 mW
Storage temperature range - - - - - - - - - - - - -	-65°C to +150°C
Lead temperature (soldering, 10 seconds) - - - - - -	+300°C
Thermal resistance, junction-to-case (θ_{JC}) - - - - -	See MIL-M-38510, appendix C
Junction temperature (T_J) - - - - - - - - - - - - -	+175°C

1.4 <u>Recommended operating conditions</u>.

Supply voltage range (V_{CC}) - - - - - - - - - - - - -	+2.0 V dc minimum to +6.0 V dc maximum
Input voltage range - - - - - - - - - - - - - - - -	0 to V_{CC}
Output voltage range - - - - - - - - - - - - - - - -	0 to V_{CC}
Input rise or fall time:	
V_{CC} = 2.0 V dc - - - - - - - - - - - - - - - - - - -	0 to 1000 ns
V_{CC} = 4.5 V dc - - - - - - - - - - - - - - - - - - -	0 to 500 ns
V_{CC} = 6.0 V dc - - - - - - - - - - - - - - - - - - -	0 to 400 ns
Case operating temperature range (T_C) - - - - - - -	-55°C to +125°C

1/ Unless otherwise specified, all voltages are referenced to ground.
2/ For T_C = +100°C to +125°C, derate linearly at 12 mW/°C.

2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following
specification and standard, of the issue listed in that issue of the Department of Defense Index of
Specifications and Standards specified in the solicitation, form a part of this drawing to the
extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510   -   Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883   -   Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific
acquisition functions should be obtained from the contracting activity or as directed by the
contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the
references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of
MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices"
and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical
dimensions shall be as specified in MIL-M-38510 and herein.

3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.

3.2.2 Truth table. The truth table shall be as specified on figure 2.

3.2.3 Test circuit and switching waveforms. The test circuit and switching waveforms shall be as
specified on figure 3.

3.2.4 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.

3.3 Electrical performance characteristics. Unless otherwise specified, the electrical
performance characteristics are as specified in table I and apply over the full case operating
temperature range.

3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall
be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number
may also be marked as listed in 6.4 herein.

3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer
in order to be listed as an approved source of supply in 6.4. The certificate of compliance
submitted to DESC-ECS prior to listing as an approved source of supply shall state that the
manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements
herein.

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TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions $-55°C \leq T_C \leq +125°C$ unless otherwise specified 1/		Group A subgroups	Limits		Unit
					Min	Max	
High level output current	I_{OH}	$V_{IN} = V_{IH}$ minimum or V_{IL} maximum $V_{OUT} = 6.0$ V	$V_{CC} = 6.0$ V	1, 2, 3		10	μA
Low level output voltage	V_{OL}	$V_{IN} = V_{IH}$ minimum or V_{IL} maximum $I_{OL} = 20$ μA	$V_{CC} = 2.0$ V	1, 2, 3		0.1	V
			$V_{CC} = 4.5$ V			0.1	
			$V_{CC} = 6.0$ V			0.1	
		$V_{IN} = V_{IH}$ minimum or V_{IL} maximum $I_{OL} = 4.0$ mA	$V_{CC} = 4.5$ V	1, 2, 3		0.4	V
		$V_{IN} = V_{IH}$ minimum or V_{IL} maximum $I_{OL} = 5.2$ mA	$V_{CC} = 6.0$ V	1, 2, 3		0.4	V
High level input voltage	V_{IH}	2/	$V_{CC} = 2.0$ V	1, 2, 3	1.5		V
			$V_{CC} = 4.5$ V	1, 2, 3	3.15		
			$V_{CC} = 6.0$ V	1, 2, 3	4.2		
Low level input voltage	V_{IL}	2/	$V_{CC} = 2.0$ V	1, 2, 3		0.3	V
			$V_{CC} = 4.5$ V	1, 2, 3		0.9	
			$V_{CC} = 6.0$ V	1, 2, 3		1.2	
Input capacitance	C_{IN}	$V_{CC} = 2.0$ V to 6.0 V see 4.3.1c	$T_C = +25°C$	4		10	pF
Supply current	I_{CC}	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0.0$	$V_{CC} = 6.0$ V	1, 2, 3		40	μA

See footnotes at end of table.

TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C ≤ T_C ≤ +125°C 1/ unless otherwise specified		Group A subgroups	Limits Min	Limits Max	Unit
Input leakage current	I_{IN}	V_{IN} = V_{CC} or GND	V_{CC} = 6.0 V	1, 2, 3		±1	μA
Functional tests		See 4.3.1d		7, 8			
Propagation delay time, from A to Y	t_{PLH}	R_L = 1 kΩ C_L = 50 pF See figure 3	V_{CC} = 2.0 V	9 10, 11		115 175	ns
		3/	V_{CC} = 4.5 V	9 10, 11		23 35	
			V_{CC} = 6.0 V	9 10, 11		20 30	
Propagation delay time, from A to Y	t_{PHL}	R_L = 1 kΩ C_L = 50 pF See figure 3	V_{CC} = 2.0 V	9 10, 11		85 130	ns
		3/	V_{CC} = 4.5 V	9 10, 11		17 26	
			V_{CC} = 6.0 V	9 10, 11		14 22	
Transition time from high to low at Y	t_{THL}	R_L = 1 kΩ C_L = 50 pF See figure 3	V_{CC} = 2.0 V	9 10, 11		75 110	ns
		3/	V_{CC} = 4.5 V	9 10, 11		15 22	
			V_{CC} = 6.0 V	9 10, 11		13 19	

1/ For a power supply of 5.0 V ±10%, the worst case output voltage (V_{OL}), for HC occur at 4.5 V. Thus, the 4.5 V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at V_{CC} = 5.5 V and 4.5 V respectively. (The V_{IH} value at 5.5 V is 3.85 V.) The worst case leakage currents (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage, so the 6.0 V values should be used. Power dissipation capacitance (C_{PD}), typically 60 pF, determines the no load dynamic power consumption, P_D = $C_{PD}V_{CC}$ ^{2}f + $I_{CC}V_{CC}$, and the no load dynamic current consumption, I_S = $C_{PD}V_{CC}$f + I_{CC}.

2/ V_{IH} and V_{IL} tests are not required if applied as a forcing function for V_{OH} and V_{OL}.

3/ AC testing at V_{CC} = 2.0 V and V_{CC} = 6.0 V shall be guaranteed, if not tested to the specified limits in table I.

3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).

3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).

4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

    a. Burn-in test, method 1015 of MIL-STD-883.

        (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

        (2) T_A = +125°C, minimum.

    b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

4.3.1 Group A inspection.

    a. Tests shall be as specified in table II herein.

    b. Subgroups 5 and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.

    c. Subgroup 4 (C_{IN} measurement) shall be measured only for the initial test and after process or design changes which may affect input capacitance. Test all applicable pins on 5 devices with zero failures.

    d. Subgroup 7 and 8 tests shall verify the truth table specified on figure 2.

4.3.2 Groups C and D inspections.

    a. End-point electrical parameters shall be as specified in table II herein.

    b. Steady-state life test conditions, method 1005 of MIL-STD-883.

        (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).

        (2) T_A = +125°C, minimum.

        (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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Device type	01	
Case outlines	C	2
Terminal number	Terminal symbol	
1	1A	NC
2	1Y	1A
3	2A	1Y
4	2Y	2A
5	3A	NC
6	3Y	2Y
7	GND	NC
8	4Y	3A
9	4A	3Y
10	5Y	GND
11	5A	NC
12	6Y	4Y
13	6A	4A
14	V_{CC}	5Y
15	---	NC
16	---	5A
17	---	NC
18	---	6Y
19	---	6A
20	---	V_{CC}

NC = No connection

FIGURE 1. Terminal connections.

Input A	Output Y
H	L
L	H

H = High voltage level
L = Low voltage level

FIGURE 2. Truth table.

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FROM OUTPUT UNDER TEST

V_{CC}

$R_L = 1 \text{ K}\Omega$

TEST POINT

$C_L = 50 \text{ pF}$

INPUT A

50%

50%

V_{CC}

0 V

t_{PHL}

t_{PLH}

OUTPUT Y

90%

50%

10%

50%

V_{OH}

V_{OL}

t_{THL}
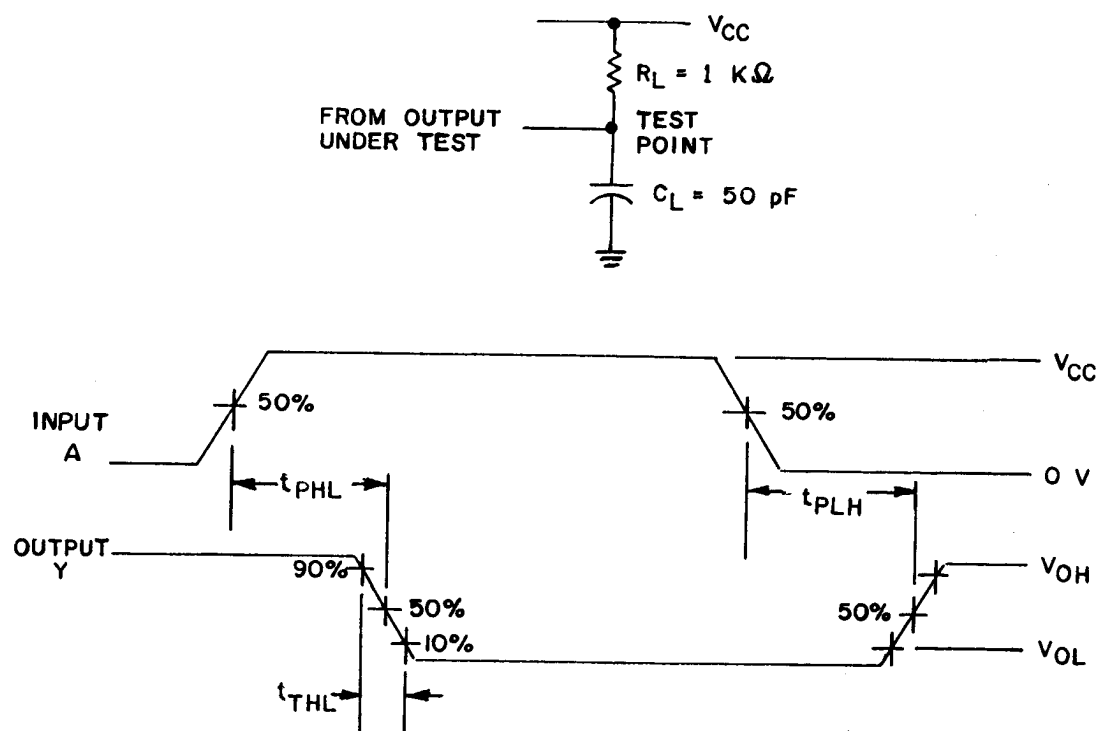
NOTES:
1. Input characteristics: PRR $\leq$ 1 MHz, Z_{OUT} = 50Ω, t_r = t_f $\leq$ 6 ns.
2. C_L includes probe and jig capacitance.

FIGURE 3. Test circuit and switching waveforms.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	---
Final electrical test parameters (method 5004)	1*, 2, 3, 7, 8, 9, 10, 11
Group A test requirements (method 5005)	1, 2, 3, 4, 7, 8, 9, 10, 11
Group C and D end-point electrical parameters (method 5005)	1, 2, 3

* PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.

6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor similar part number 1/
5962-8871801CX	01295	SNJ54HC05J
5962-88718012X	01295	SNJ54HC05FK

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name and address
01295	Texas Instruments, Incorporated P.O. Box 60448 Midland, TX 79711-0448

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